

Notice of References Cited	Application/Control No. 10/713,285	Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Linh T. Nguyen	Art Unit 2627	Page 1 of 1

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*	B	US-2002/0114233	08-2002	Sasaki et al.	369/47.51
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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